

AOT2146L/AOB2146L

40V N-Channel AlphaSGT™

General Description

- Trench Power AlphaSGT[™] technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized Ruggedness
- RoHS and Halogen-Free Compliant

Product Summary

 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 105A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.8 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 3.9 m\Omega \end{array}$

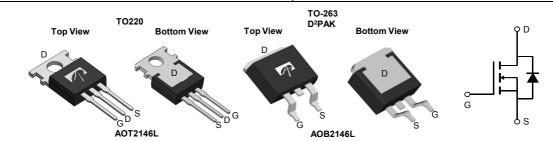
100% UIS Tested 100% Rg Tested



Applications

• DC Motor Driver

• Synchronous Rectification in DC/DC and AC/DC Converters



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT2146L	TO-220	Tube	1000
AOB2146L	TO-263	Tape & Reel	800

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25°C		105		
Current G	T _C =100°C	'D	100	A	
Pulsed Drain Current ^C		I _{DM}	345		
Continuous Drain	T _A =25°C		42	Α	
Current	T _A =70°C	IDSM	33.5		
Avalanche Current ^C		I _{AS}	38	Α	
Avalanche energy	L=0.3mH	E _{AS}	217	mJ	
Power Dissipation ^B	T _C =25°C	В	119	W	
	T _C =100°C	P _D	47.5	VV	
Power Dissipation A	T _A =25°C	Р	8.3	— w	
	T _A =70°C	P _{DSM}	5.3		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	12	15	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	50	60	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.85	1.05	°C/W	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		40			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =40V, V _{GS} =0V	V _{DS} =40V, V _{GS} =0V			1	
			T _J =55°C			5	μA
I_{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.5	1.95	2.5	V
	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =20A			2.3	2.8	mΩ
R _{DS(ON)}			T _J =125°C		3.5	4.3	
		V_{GS} =4.5V, I_D =20A			3.1	3.9	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			100		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.68	1	V
Is	Maximum Body-Diode Continuous Cur	rent ^G			105	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance				3830		pF
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =20V, f=1MHz			630		pF
C _{rss}	Reverse Transfer Capacitance				45		pF
R_g	Gate resistance	f=1MHz		1	2	3	Ω
SWITCHI	NG PARAMETERS	•	•		•	•	•
Q _g (10V)	Total Gate Charge				50	70	nC
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =20V,	I-=20Δ		20	30	nC
Q_{gs}	Gate Source Charge	- V _{GS} - 10V, V _{DS} -20V, I _D -20A			13.5		nC
Q_{gd}	Gate Drain Charge				3		nC
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =20V			27		nC
t _{D(on)}	Turn-On DelayTime				12		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_L =1.0 Ω , R_{GEN} =3 Ω			12		ns
t _{D(off)}	Turn-Off DelayTime				44		ns
t _f	Turn-Off Fall Time				9		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs			18.5		ns
Q_{rr}	Body Diode Reverse Recovery Charge	l _F =20A, di/dt=500A/μs			50		nC

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{8JA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}\text{=}150^{\circ}\,$ C.

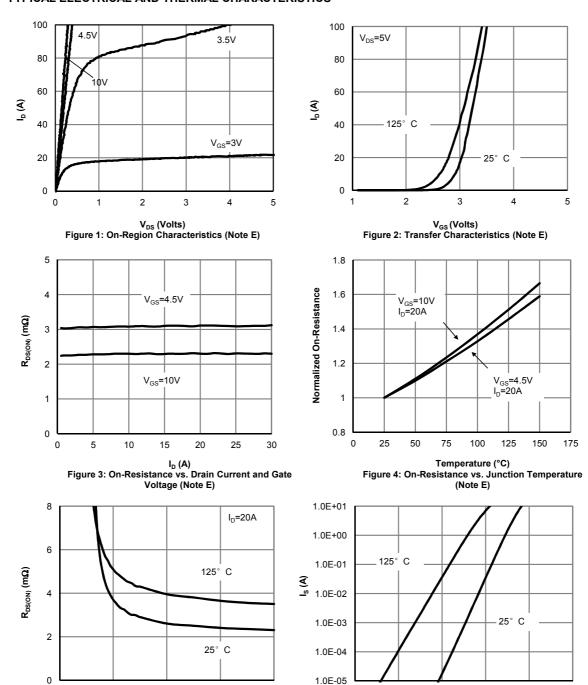
D. The R_{NJA} is the sum of the thermal impedance from junction to case R_{NJC} and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



2

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



8

6

V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

10

0.0

0.2

0.4

V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

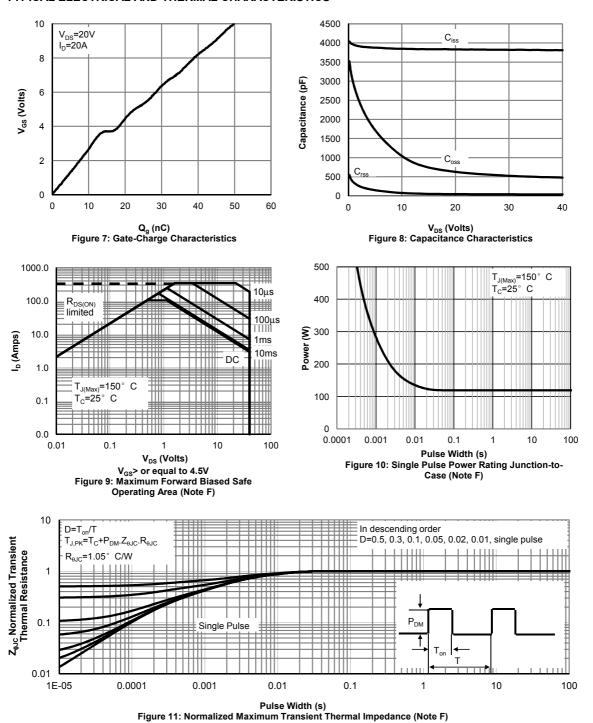
0.6

0.8

1.0

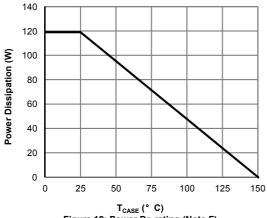


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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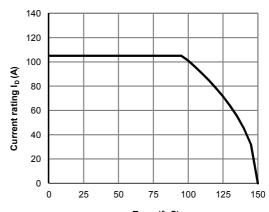
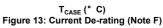
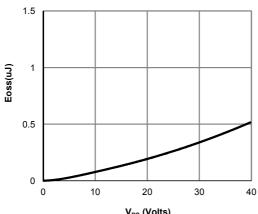
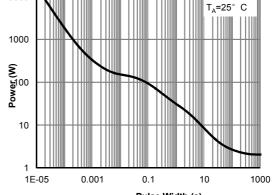


Figure 12: Power De-rating (Note F)

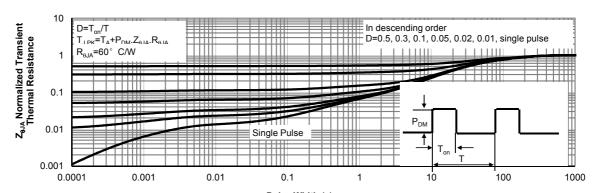






V_{DS} (Volts) Figure 14: Coss stored Energy

Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)



10000

Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



Figure A: Gate Charge Test Circuit & Waveforms

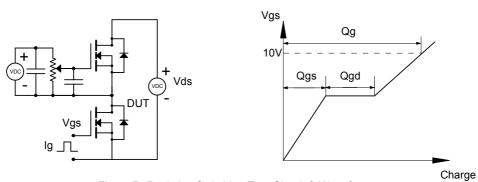


Figure B: Resistive Switching Test Circuit & Waveforms

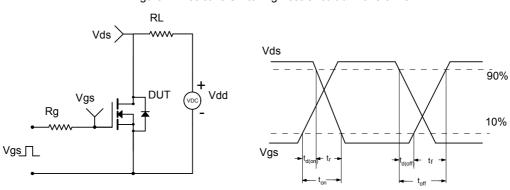


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

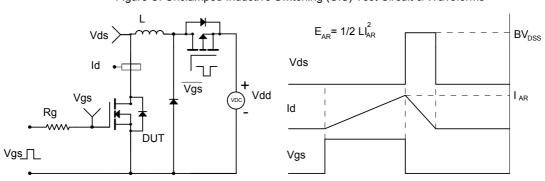
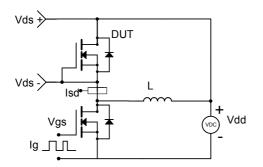
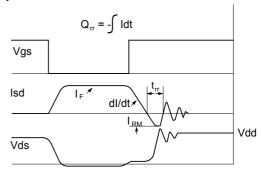


Figure D: Diode Recovery Test Circuit & Waveforms





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